BFU690F

NPN wideband silicon RF transistor

Rev. 0.8 — 23 November 2010

Product data sheet

1. Product profile

1.1 General description

NPN silicon microwave transistor for high speed, low noise applications in a plastic, 4-pin dual-emitter SOT343F package.

CAUTION



This device is sensitive to ElectroStatic Discharge (ESD). Observe precautions for handling electrostatic sensitive devices.

Such precautions are described in the ANSI/ESD S20.20, IEC/ST 61340-5, JESD625-A or equivalent standards.

1.2 Features and benefits

- Low noise high linearity microwave transistor
- High output third-order intercept point 34 dBm at 1.8 GHz
- 40 GHz f_T silicon technology

1.3 Applications

- Ka band oscillators DRO's
- C-band high ouput buffer amplifier
- ZigBee
- LTE, cellular, UMTS





1.4 Quick reference data

Table 1. Quick reference data

Symbol	Parameter	Conditions	Min	Тур	Max	Unit
V_{CBO}	collector-base voltage	open emitter	-	-	16	V %
V_{CEO}	collector-emitter voltage	open base	-	-	5.5	V
V_{EBO}	emitter-base voltage	open collector	-	-	2.5	V
I _C	collector current		-	70	100	mA
P _{tot}	total power dissipation	$T_{sp} \le 90 ^{\circ}C$	<u>[1]</u> _	-	230	mW
h _{FE}	DC current gain	$I_C = 20 \text{ mA}; V_{CE} = 2 \text{ V};$ $T_j = 25 \text{ °C}$	90	135	180	
C_{CBS}	collector-base capacitance	$V_{CB} = 2 \text{ V}; f = 1 \text{ MHz}$	-	404	-	fF
f _T	transition frequency	I_C = 60 mA; V_{CE} = 1 V; f = 2 GHz; T_{amb} = 25 °C	Ī	18	-	GHz
$G_{p(max)}$	maximum power gain	I_C = 60 mA; V_{CE} = 1 V; f = 1.8 GHz; T_{amb} = 25 °C	[2] -	20.5	-	dB
NF	noise figure	I_C = 15 mA; V_{CE} = 2 V; f = 1.8 GHz; Γ_S = Γ_{opt}	-	0.65	-	dB
P _{L(1dB)}	output power at 1 dB gain compression	$I_{C} = 70 \text{ mA}; V_{CE} = 4 \text{ V};$ $Z_{S} = Z_{L} = 50 \Omega;$ $f = 1.8 \text{ GHz}; T_{amb} = 25 ^{\circ}\text{C}$	-	22	-	dBm

^[1] T_{sp} is the temperature at the solder point of the emitter lead.

2. Pinning information

Table 2. Discrete pinning

Pin	Description	Simplified outline	Graphic symbol
1	emitter		
2	base	3 4	4
3	emitter		2
4	collector		1, 3
		2 1	mbb159

3. Ordering information

Table 3. Ordering information

Type number	Package		
	Name	Description	Version
BFU690F	-	plastic surface-mounted flat pack package; reverse pinning; 4 leads	SOT343F

^[2] $G_{p(max)}$ is the maximum power gain, if K > 1. If K < 1 then $G_{p(max)}$ = Maximum Stable Gain (MSG).

Marking 4.

Table 4. **Marking**

Type number	Marking	Description
BFU690F	D4*	* = p : made in Hong Kong
		* = t : made in Malaysia
		* = w : made in China

Limiting values

Table 5. **Limiting values**

In accordance with the Absolute Maximum Rating System (IEC 60134).

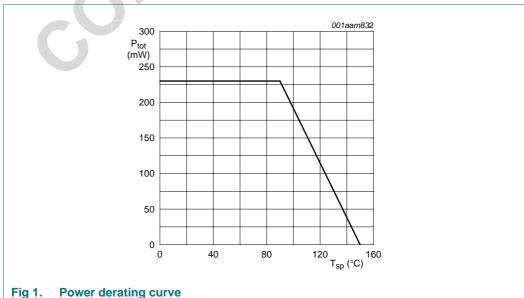
Symbol	Parameter	Conditions	Min	Max	Unit
V_{CBO}	collector-base voltage	open emitter	-	16	V
V _{CEO}	collector-emitter voltage	open base	6	5.5	V
V _{EBO}	emitter-base voltage	open collector		2.5	V
I _C	collector current		-	100	mA
P _{tot}	total power dissipation	T _{sp} ≤ 90 °C	[1] -	230	mW
T _{stg}	storage temperature		-65	+150	°C
T _j	junction temperature		-	150	°C

^[1] T_{sp} is the temperature at the solder point of the emitter lead.

Thermal characteristics

Thermal characteristics Table 6.

Symbol	Parameter	Conditions	Тур	Unit
$R_{th(j-sp)}$	thermal resistance from junction to solder point		260	K/W

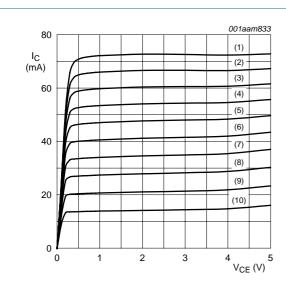


Characteristics

Table 7. **Characteristics**

NXP Se	emiconductors	NPN wideb	Op	DL	UO:	JUL
		NPN wideb	and sil	icon R	RF tran	nsisto
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7. Ch	naracteristics				P	Opp
					\\\\\\\\\\\\\\\\\\\\\\\\\\\\\\\\\\\\\\),
Γable 7. Γ _j = 25 ℃	Characteristics unless otherwise specified					P. A.
Symbol	Parameter	Conditions	Min	Тур	Max	Unit
$V_{(BR)CBO}$	collector-base breakdown voltage	$I_C = 2.5 \mu A; I_E = 0 \text{ mA}$	16	-	-	V
$V_{(BR)CEO}$	collector-emitter breakdown voltage	$I_C = 1 \text{ mA}$; $I_B = 0 \text{ mA}$	5.5	-	-	V
c	collector current		-	70	100	mΑ
Ісво	collector-base cut-off current	$I_E = 0 \text{ mA}; V_{CB} = 8 \text{ V}$	-	-	100	nA
n _{FE}	DC current gain	$I_C = 20 \text{ mA}; V_{CE} = 2 \text{ V}$	90	135	180	
C _{CES}	collector-emitter capacitance	$V_{CB} = 2 \text{ V}; f = 1 \text{ MHz}$	-	527	-	fF
C _{EBS}	emitter-base capacitance	V _{EB} = 0.5 V; f = 1 MHz	-	1699	-	fF
CBS	collector-base capacitance	$V_{CB} = 2 \text{ V}; f = 1 \text{ MHz}$	-	404	-	fF
Т	transition frequency	$I_C = 60 \text{ mA}; V_{CE} = 1 \text{ V}; f = 2 \text{ GHz};$ $T_{amb} = 25 ^{\circ}\text{C}$	•	18	-	GHz
$G_{p(max)}$	maximum power gain	$I_C = 60 \text{ mA}; V_{CE} = 1 \text{ V}; T_{amb} = 25 ^{\circ}\text{C}$	1]			
		f = 1.5 GHz	-	22	-	dB
		f = 1.8 GHz	-	20.5	-	dB
		f = 2.4 GHz	-	17	-	dB
$ S_{21} ^2$	insertion power gain	I_C = 60 mA; V_{CE} = 1 V; T_{amb} = 25 °C				
		f = 1.5 GHz	-	15	-	dB
		f = 1.8 GHz	-	13.5	-	dB
		f = 2.4 GHz	-	11	-	dB
۱F	noise figure	I_C = 15 mA; V_{CE} = 2 V; Γ_S = Γ_{opt} ; Γ_{amb} = 25 °C				
		f = 1.5 GHz	-	0.60	-	dB
		f = 1.8 GHz	-	0.65	-	dB
		f = 2.4 GHz	-	0.70	-	dB
Sass	associated gain	I_C = 15 mA; V_{CE} = 2 V; Γ_S = Γ_{opt} ; Γ_{amb} = 25 °C				
		f = 1.5 GHz	-	18.5	-	dB
		f = 1.8 GHz	-	17.5	-	dB
		f = 2.4 GHz	-	15.5	-	dB
L(1dB)	output power at 1 dB gain compression	I_{C} = 70 mA; V_{CE} = 4 V; Z_{S} = Z_{L} = 50 Ω ; T_{amb} = 25 °C				
		f = 1.5 GHz	-	22	-	dBm
		f = 1.8 GHz	-	22	-	dBm
		f = 2.4 GHz	-	20	-	dBm
P3	third-order intercept point	I_{C} = 70 mA; V_{CE} = 4 V; Z_{S} = Z_{L} = 50 Ω ; T_{amb} = 25 °C				
		f = 1.5 GHz	-	34	-	dBm
		f = 1.8 GHz	-	34	-	dBm
		f = 2.4 GHz		33	-	dBm

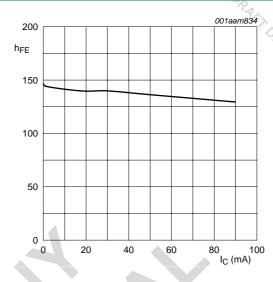
^[1] $G_{p(max)}$ is the maximum power gain, if K>1. If K<1 then $G_{p(max)}=MSG$.



 $T_{amb} = 25 \, ^{\circ}C.$

- (1) $I_B = 550 \mu A$
- (2) $I_B = 500 \mu A$
- (3) $I_B = 450 \mu A$
- (4) $I_B = 400 \mu A$
- (5) $I_B = 350 \mu A$
- (6) $I_B = 300 \mu A$
- (7) $I_B = 250 \mu A$ (8) $I_B = 200 \mu A$
- (9) $I_B = 150 \mu A$
- (10) $I_B = 100 \mu A$

Fig 2. Collector current as a function of collector-emitter voltage; typical values



 $V_{CE} = 2 \text{ V}; T_{amb} = 25 \,^{\circ}\text{C}.$

Fig 3. DC current gain as a function of collector current; typical values

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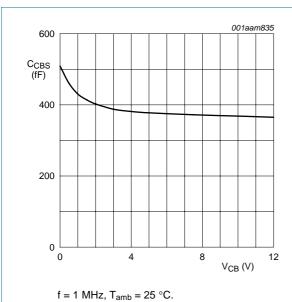
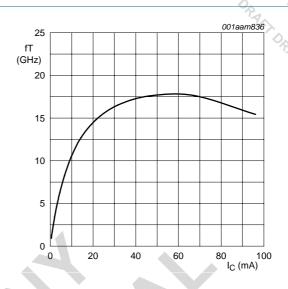
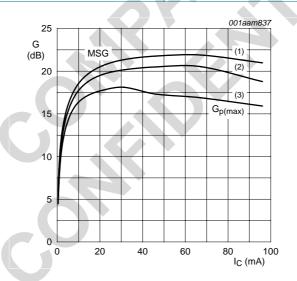


Fig 4. Collector-base capacitance as a function of collector-base voltage; typical values



 $V_{CE} = 1 \text{ V; } f = 2 \text{ GHz; } T_{amb} = 25 \text{ }^{\circ}\text{C.}$

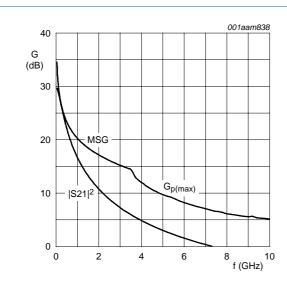
Fig 5. Transition frequency as a function of collector current; typical values



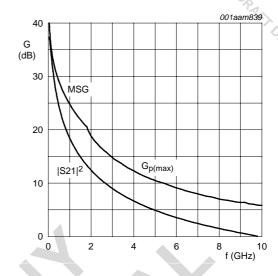
 $V_{CE} = 1 \text{ V}; T_{amb} = 25 \text{ }^{\circ}\text{C}.$

- (1) f = 1.5 GHz
- (2) f = 1.8 GHz
- (3) f = 2.4 GHz

Fig 6. Gain as a function of collector current; typical value



 V_{CE} = 1 V; I_{C} = 10 mA; T_{amb} = 25 °C.



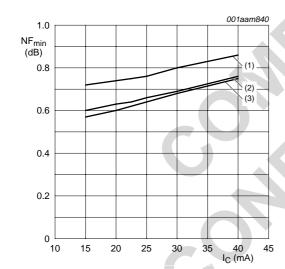
 $V_{CE} = 1 \text{ V; } I_{C} = 60 \text{ mA; } T_{amb} = 25 \text{ °C.}$

Gain as a function of frequency; typical values

Fig 8.

Fig 7. Gain as a function of frequency; typical values

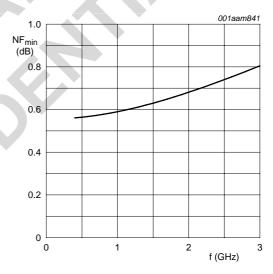




 $V_{CE} = 2 \text{ V}; T_{amb} = 25 \text{ °C}.$

- (1) f = 2.4 GHz
- (2) f = 1.8 GHz
- (3) f = 1.5 GHz

Minimum noise figure as a function of Fig 9. collector current; typical values



 V_{CE} = 2 V; I_{C} = 15 mA; T_{amb} = 25 °C.

Fig 10. Minimum noise figure as a function of frequency; typical values

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8. Package outline

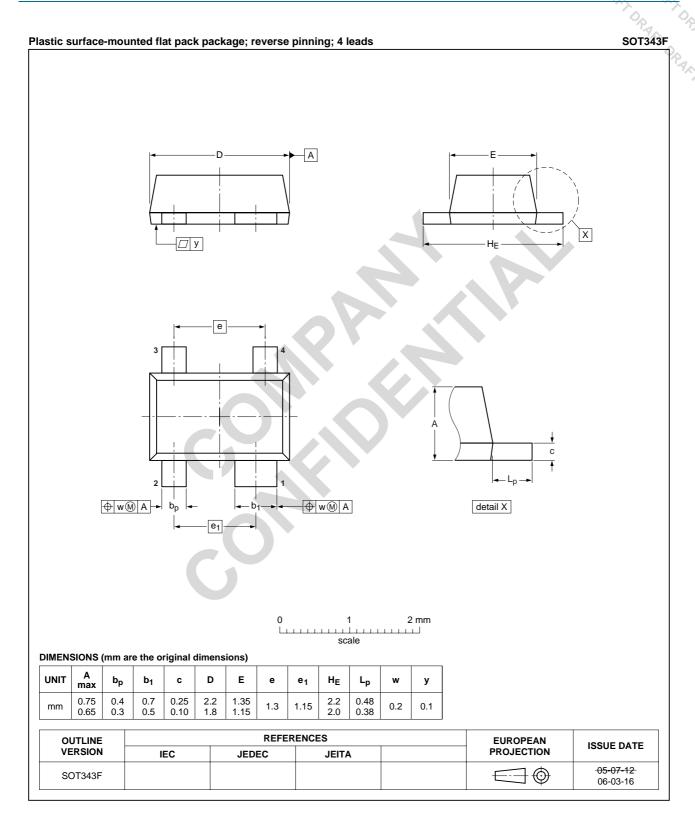


Fig 11. Package outline SOT343F



9. Abbreviations

Table 8. Abbreviations

	7,555
Acronym	Description
DBS	Direct Broadcast Satellite
DC	Direct Current
DRO	Dielectric Resonator Oscillator
Ka	Kurtz above
LNA	Low Noise Amplifier
LNB	Low Noise Block
LTE	Long Term Evolution
NPN	Negative-Positive-Negative
RF	Radio Frequency
UMTS	Univeral Mobile Telecommunications System

10. Revision history

Table 9. Revision history

Document ID	Release date	Data sheet status	Change notice	Supersedes
BFU690F v.1	<tbd></tbd>	Product data sheet	-	-

11. Legal information

11.1 Data sheet status

NXP Semiconduc	tors	BFU690F
		NPN wideband silicon RF transistor
11. Legal infor	mation	DRA DRA DRA
11.1 Data sheet	status	DRANT DRANT
Document status[1][2]	Product status[3]	Definition
Objective [short] data sheet	Development	This document contains data from the objective specification for product development.
Preliminary [short] data sheet	Qualification	This document contains data from the preliminary specification.
Product [short] data sheet	Production	This document contains the product specification.

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- [2] The term 'short data sheet' is explained in section "Definitions"
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